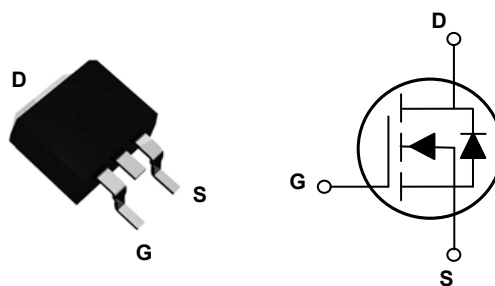


Main Product Characteristics

$V_{(BR)DSS}$	100V
$R_{DS(ON)}$	27mΩ (Max.)
I_D	48A



TO-263 (D²PAK)

Schematic Diagram

Features and Benefits

- Advanced MOSFET process technology
- Ideal for high efficiency switched mode power supplies
- Low on-resistance with low gate charge
- Fast switching and reverse body recovery



Description

The GSFT27010 utilizes the latest techniques to achieve high cell density and low on-resistance. These features make this device extremely efficient and reliable for use in high efficiency switch mode power supplies and a wide variety of other applications.

Absolute Maximum Ratings ($T_A=25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V_{DS}	100	V
Gate-to-Source Voltage	V_{GS}	±20	V
Continuous Drain Current, @ Steady-State ($T_C=25^{\circ}C$) ¹	I_D	48	A
Continuous Drain Current, @ Steady-State ($T_C=100^{\circ}C$) ¹		34	A
Pulsed Drain Current ($T_C=25^{\circ}C$) ²	I_{DM}	180	A
Power Dissipation ($T_C=25^{\circ}C$) ³	P_D	160	W
Single Pulse Avalanche Energy	E_{AS}	9.8	mJ
Single Pulse Avalanche Current	I_{AS}	14	A
Thermal Resistance, Junction-to-Ambient (PCB Mounted, Steady-State)	$R_{\theta JA}$	62	°C/W
Thermal Resistance, Junction-to-Case	$R_{\theta JC}$	2.08	°C/W
Operating Junction and Storage Temperature Range	T_J/T_{STG}	-55 to +150	°C
Soldering Temperature (SMD)	T_{sold}	260	°C

Electrical Characteristics ($T_A=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
On / Off Characteristics						
Drain-to-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS}=0V, I_D=250\mu A$	100	-	-	V
Drain-to-Source Leakage Current	I_{DSS}	$V_{DS}=100V, V_{GS}=0V, T_J=25^\circ\text{C}$	-	-	1.0	μA
		$V_{DS}=100V, V_{GS}=0V, T_J=125^\circ\text{C}$	-	1.2	-	
Gate-to-Source Forward Leakage	I_{GSS}	$V_{DS}=0V, V_{GS}=20V$	-	-	100	nA
		$V_{DS}=0V, V_{GS}=-20V$	-	-	-100	
Static Drain-to-Source On-Resistance	$R_{DS(ON)}$	$V_{GS}=10V, I_D=15A$	-	19	27	$m\Omega$
		$V_{GS}=4.5V, I_D=10A$	-	32	40	
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=250\mu A$	1.1	-	2.9	V
Dynamic and Switching Characteristics						
Input Capacitance	C_{iss}	$V_{GS}=0V, V_{DS}=50V, f=1\text{MHz}$	-	1056	-	pF
Output Capacitance	C_{oss}		-	131	-	
Reverse Transfer Capacitance	C_{rss}		-	3.8	-	
Total Gate Charge ^{4,5}	Q_g	$I_D=10A, V_{DD}=50V, V_{GS}=10V$	-	16	-	nC
Gate-to-Source Charge ^{4,5}	Q_{gs}		-	4.1	-	
Gate-to-Drain ("Miller") Charge ^{4,5}	Q_{gd}		-	3.7	-	
Gate Plateau ^{4,5}	$V_{plateau}$		-	4.0	-	V
Turn-On Delay Time ^{4,5}	$t_{d(on)}$	$V_{DD}=50V, V_{GS}=10V, R_G=1.6\Omega, I_D=10A$	-	6.4	-	nS
Rise Time ^{4,5}	t_r		-	30	-	
Turn-Off Delay Time ^{4,5}	$t_{d(off)}$		-	21	-	
Fall Time ^{4,5}	t_f		-	9.4	-	
Gate Resistance	R_g	$f=1\text{MHz}$	-	1.9	-	Ω
Drain-Source Ratings and Characteristics						
Continuous Source Current (Body Diode)	I_S	MOSFET symbol showing the integral reverse p-n junction diode.	-	-	48	A
Diode Pulse Current	$I_{S,pulse}$		-	-	180	A
Diode Forward Voltage	V_{SD}	$I_S=10A, V_{GS}=0V$	-	-	1.4	V
Reverse Recovery Time ⁴	t_{rr}	$I_S=10A, V_{GS}=0V, V_R=50V, di_f/dt=100A/\mu s$	-	35	-	nS
Reverse Recovery Charge ⁴	Q_{rr}		-	38	-	nC

Note:

1. The rated value only refers to the maximum absolute value under 25°C shell temperature in the manual. If the shell temperature is higher than 25°C , the rating shall be reduced according to the actual environmental conditions.
2. Pulse time 5 μs , and the pulse width is limited to the maximum junction temperature.
3. The value of dissipated power will change with the temperature. When the temperature is higher than 25°C , the value of dissipated power will decrease by $0.04W/^\circ\text{C}$ with each temperature rise of 1°C .
4. Pulse test: Pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$.
5. Essentially independent of operating temperature.

Typical Electrical and Thermal Characteristic Curves

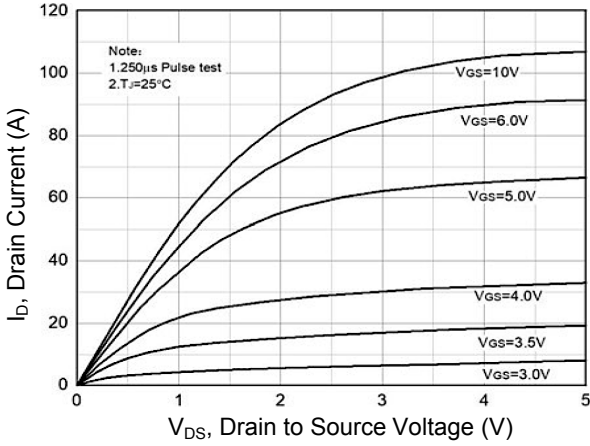


Figure 1. Typical Output Characteristics

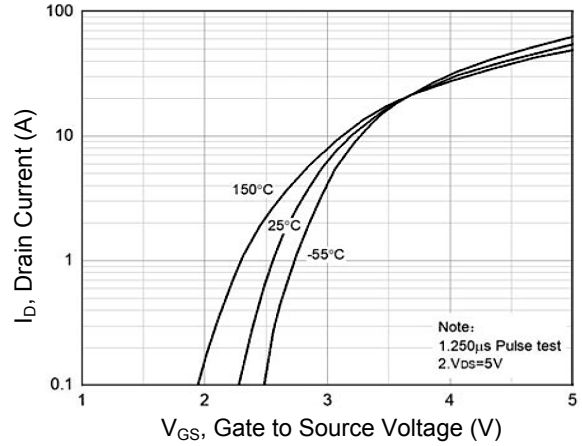


Figure 2. Transfer Characteristics

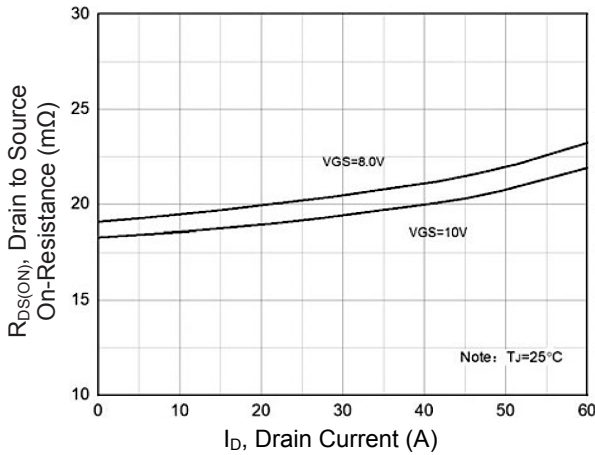


Figure 3. $R_{DS(ON)}$ vs. I_D

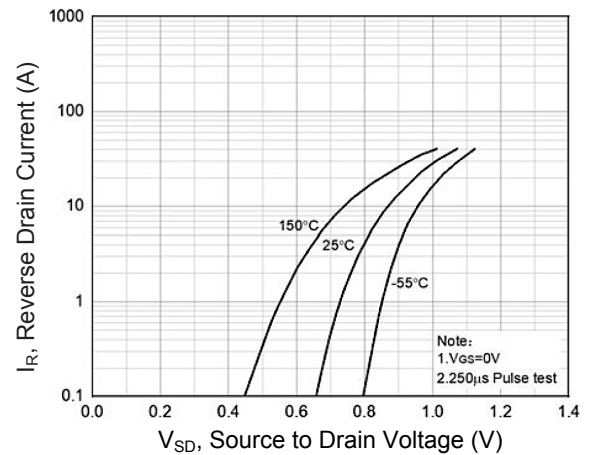


Figure 4. Body Diode Characteristics

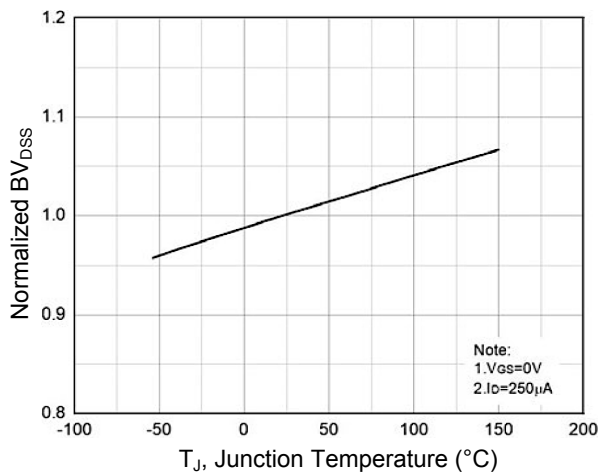


Figure 5. Normalized BV_{DSS} vs. T_J

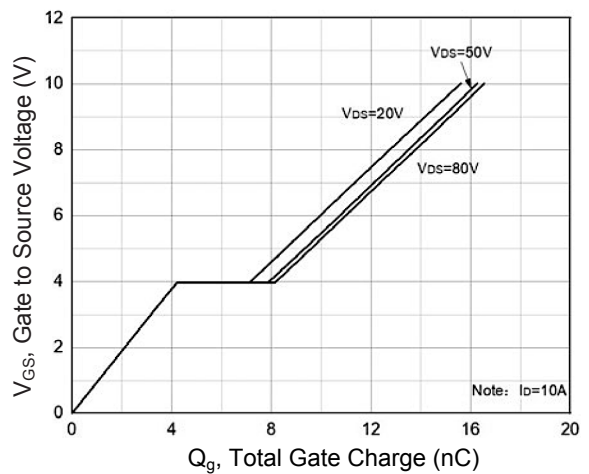


Figure 6. Gate Charge

Typical Electrical and Thermal Characteristic Curves

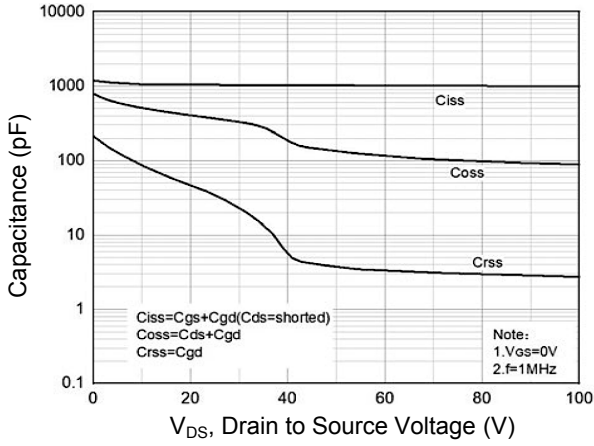


Figure 7. Capacitance Characteristic

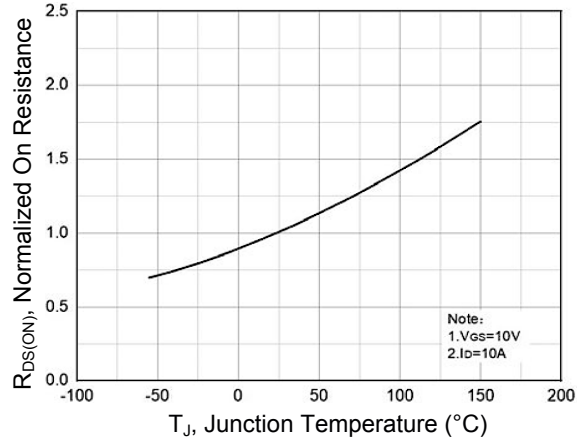


Figure 8. Normalized $R_{DS(ON)}$ vs. T_J

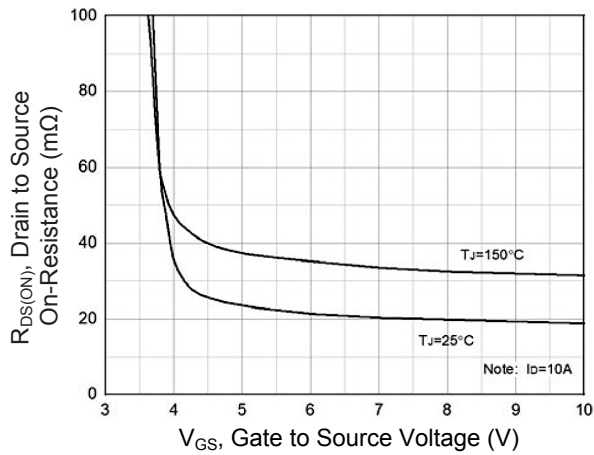


Figure 9. $R_{DS(ON)}$ vs. V_{GS}

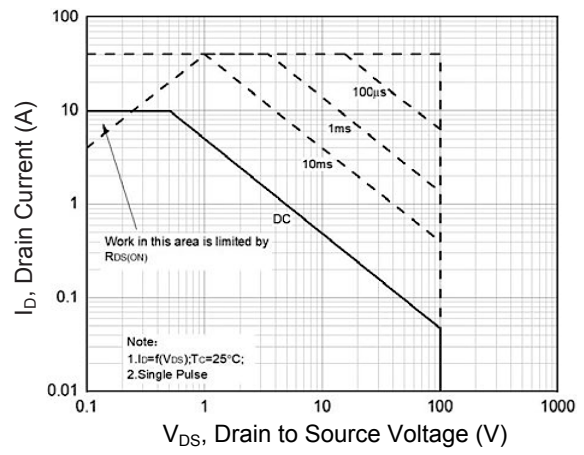
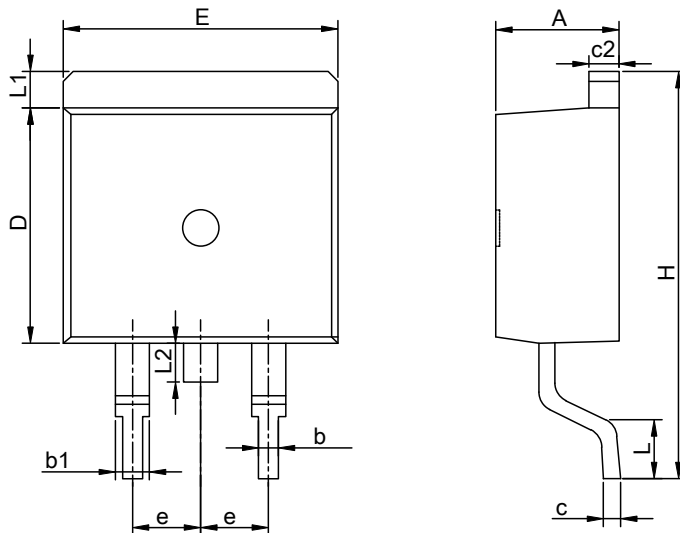


Figure 10. Safe Operation Area

Package Outline Dimensions TO-263 (D²PAK)



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	4.30	4.90	0.169	0.193
b	0.70	0.95	0.028	0.037
b1	1.07	1.50	0.042	0.059
c	0.28	0.60	0.011	0.024
c2	1.17	1.37	0.046	0.054
D	8.40	9.35	0.331	0.368
E	9.80	10.45	0.386	0.411
e	2.54 BSC		0.100 BSC	
H	14.70	16.30	0.579	0.642
L	2.00	3.80	0.079	0.150
L1	0.97	1.42	0.038	0.056
L2	-	1.75	-	0.069

Order Information

Device	Package	Marking	Packaging	SPQ
GSFT27010	TO-263 (D ² PAK)	T27010	Tape & Reel	800 Pcs / Reel

For more information, please contact us at: inquiry@goodarksemi.com